DAFTAR PUSTAKA

[1] Kemdikbud, "Latar belakang kurikulum merdeka – merdeka mengajar," *kemdikbud*, 3 2023. [Online]. Available: https://pusatinformasi.guru.kemdikbud.go.id/hc/en-us/articles/6824331505561-Latar-Belakang-Kurikulum-Merdeka

[2] J. Nugraha, "Mengenal tujuan kurikulum merdeka, pahami bedanya dengan kurikulum sebelumnya — merdeka.com." [Online]. Available: https://www.merdeka.com/jateng/mengenal-tujuan-kurikulum-merdeka-dan-penjelasannya-perlu-diketahui-kln.html

[3] S. Panjwani, S. N. Kumar, and L. Ahuja, "Multi-criteria decision making and its applications," *International Journal of Innovative Technology and Exploring Engineering*, vol. 8, 2019.

[4] R. Kumar, A. Bhattacherjee, A. D. Singh, S. Singh, and C. I. Pruncu, "Selection of portable hard disk drive based upon weighted aggregated sum product assessment method: A case of indian market," *Measurement and Control (United Kingdom)*, vol. 53, 2020.

[5] F. O. Isinkaye, Y. O. Folajimi, and B. A. Ojokoh, "Recommendation systems: Principles, methods and evaluation," *Egyptian Informatics Journal*, vol. 16, pp. 261–273, 11 2015.

[6] E. K. Zavadskas, Z. Turskis, J. Antucheviciene, and A. Zakarevicius, "Optimization of weighted aggregated sum product assessment," *Elektronika ir Elektrotechnika*, vol. 122, pp. 3–6, 2012. [Online]. Available: https://www.researchgate.net/publication/277246947_Optimization_of_Weighted_Aggregated_Sum_Product_Assessment

[7] S. Sorooshian, N. A. Azizan, and N. A. Ebrahim, "Weighted aggregated sum product assessment," *Mathematical Modelling of Engineering Problems*, vol. 9, 2022.

[8] W. Chin and M. Lee, "On the formation of end-user computing satisfaction: A proposed model and measurement instrument," 07 1999.

[9] A. Joshi, S. Kale, S. Chandel, and D. K. Pal, "Likert scale: Explored and explained," vol. BJAST, p. 157, 2015.

[10] D. Lakshmi and S. Mallika, "A review on web application testing and its current research directions," *International Journal of Electrical and Computer Engineering (IJECE)*, vol. 7, p. 2132, 08 2017.

[11] S. Nidhra, "Black box and white box testing techniques - a literature review," *International Journal of Embedded Systems and Applications*, vol. 2, pp. 29–50, 06 2012.